

## 3V WCDMA BAND 3 LINEAR PA MODULE

Package Style: Module, 10-Pin, 3mm x 3mm x 1.0mm RFMD [90] RF7413

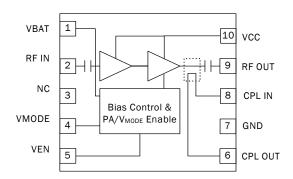


## **Features**

- HSDPA/HSUPA/HSPA+/LTE
- High Efficiency WCDMA Operation: 41% at  $P_{OLIT} = +28dBm$
- Low Voltage Positive Bias Supply (3.0V to 4.2V)
- Internal Voltage Regulator -No External (V<sub>RFF</sub>) Required
- Two Mode Power/Gain States with Digital Control Interface
- Integrated Power Coupler
- Integrated Blocking and **Decoupling Capacitors**

## **Applications**

- WCDMA/HSPA+/LTE Wireless **Data Cards**
- WCDMA/HSPA+/LTE Handsets



Functional Block Diagram

## **Product Description**

The RF7413 is a high-power, high-efficiency, linear power amplifier designed for use as the final RF amplifier in 3V,  $50\Omega$  WCDMA mobile cellular equipment and spread-spectrum systems. This PA is developed for UMTS Band 3 which operates in the 1710MHz to 1785MHz frequency band. The RF7413 has a digital control pin which enables a low power mode to reduce amplifier gain at lower power levels. The part also has an integrated directional coupler which eliminates the need for an external discrete coupler at the output. The RF7413 (Band 3) meets the spectral linearity requirements of High Speed Downlink Packet Access (HSDPA), High Speed Uplink Packet Access (HSUPA), and Long Term Evolution (LTE) data transmission. The RF7413 is assembled in a 10-pin, 3mm x 3mm module.

## **Ordering Information**

RF7413 3V WCDMA Band 3 Linear PA Module RF7413PCBA-410 Fully Assembled Evaluation Board

Optimum recimology watchings Applied				
☐ GaAs HBT	☐ SiGe BiCMOS	☐ GaAs pHEMT	☐ GaN HEM1	
☐ GaAs MESFET  ✓ InGaP HBT	☐ Si BiCMOS	☐ Si CMOS	☐ BiFET HBT	
▼ InGaP HBT	☐ SiGe HBT	☐ Si BJT	LDMOS	



## **Absolute Maximum Ratings**

Parameter	Rating	Unit
Supply Voltage in Standby Mode	6.0	V
Supply Voltage in Idle Mode	6.0	V
Supply Voltage in Operating Mode, $50\Omega$ Load	6.0	V
Supply Voltage, V <sub>BAT</sub>	6.0	V
Control Voltage, V <sub>MODE</sub>	3.7	V
Control Voltage, V <sub>EN</sub>	3.7	V
RF - Input Power	+10	dBm
RF - Output Power	+30	dBm
Operating Ambient Temperature	-30 to +110	°C
Storage Temperature	-55 to +150	°C



## Caution! ESD sensitive device.

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability. Specified by pical performance or functional operation of the device under Absolute Maximum Rating conditions is not implied.

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RFMD Green: RoHS compliant per EU Directive 2002/95/EC, halogen free per IEC 61249-2-21, < 1000 ppm each of antimony trioxide in polymeric materials and red phosphorus as a flame retardant, and <2% antimony in solder.

Parameter	Specification		Heit	Condition		
Farameter	Min. Typ.		Max.	Unit	Condition	
Recommended Operating Conditions						
Operating Frequency Range	1710		1785	MHz		
V <sub>BAT</sub>	+3.0	+3.2	+4.2	V		
V <sub>CC</sub>	+3.0 <sup>1</sup>	+3.2	+4.2	V		
V <sub>CC</sub> (used with DC-DC)	0.5		+4.2	V	PA used with DC-DC converter to reduce cur- rent drain at back-off and lower power levels	
V <sub>EN</sub>	0		0.5	V	PA disabled.	
	1.35	1.80	3.10	V	PA enabled.	
V <sub>MODE</sub>	0		0.5	V	Logic "low".	
	1.35	1.80	3.10	V	Logic "high".	
P <sub>OUT</sub>						
Maximum Linear Output (HPM)	28.0 <sup>1,2</sup>			dBm	High Power Mode (HPM)	
Maximum Linear Output (LPM)	16.0 <sup>1,2</sup>			dBm	Low Power Mode (LPM)	
Ambient Temperature	-20	+25	+85	°C		

### Notes:

HSDPA Configuration: βc=12, βd=15, βhs=24 HSPA+ Configuration: 3GPP ReI7 Subtest 1

 $<sup>^{1}\!\</sup>text{For operation at V}_{\text{CC}}\!\!=\!+3.0\text{V},$  derate  $\text{P}_{\text{OUT}}$  by 0.5dB.

 $<sup>^2</sup>$ P<sub>OUT</sub> is specified for 3GPP (Voice) modulation. For HSDPA and HSPA+ operation, derate P<sub>OUT</sub> by 2dB:



**Specification** Unit Condition **Parameter** Min. Тур. Max. T=+25 °C,  $V_{CC}=V_{BAT}=+3.2V$ ,  $V_{FN}=+1.8V$ ,  $50\Omega$ **Electrical Specifications** system, WCDMA Rel 99 Modulation unless otherwise specified. Gain 31 dB HPM, P<sub>OUT</sub>=28.0dBm 17.5 dB LPM,  $P_{OUT} \le 16.0dBm$ ACLR - 5MHz Offset -41 -36 HPM, P<sub>OUT</sub>=28.0dBm dBc -46 -38 dBc LPM,  $P_{OUT} \le 16.0dBm$ ACLR - 10MHz Offset -55 -48 dBc HPM, P<sub>OUT</sub>=28.0dBm -68 -48 dBc LPM,  $P_{OUT} \le 16.0dBm$ PAE 38 41 % HPM, POUT=28.0dBm 10 % LPM,  $P_{OUT} \leq 16.0dBm$ **Current Drain** HPM, P<sub>OUT</sub>=28.0dBm 452 mA 125 mA LPM,  $P_{OUT} \le 16.0dBm$ HPM, DC only Quiescent Current 50 mA **Enable Current** 0.03 Source or sink current. V<sub>EN</sub>=1.8V. mΑ 0.01 Source or sink current.  $V_{MODE}$ =1.8V. Mode Current (I<sub>MODE</sub>) mΑ Leakage Current 20 10.0 DC only.  $V_{CC}=V_{BAT}=4.2V$ ,  $V_{EN}=V_{MODE}=0.5V$ . μΑ All power modes, measured at duplex offset Noise Power in Receive Band -133 dBm/Hz frequency (F<sub>TX</sub> + 95MHz). Rx: 1805MHz to 1880MHz,  $P_{OUT} \le 28.0$ dBm. VSWR Input Impedance 1.6:1 No ext. matching, P<sub>OUT</sub> ≤ 28dBm, all modes. Harmonic, 2FO -21 -7 dBm  $P_{OLIT} \le 28.0 dBm$ , all power modes. Harmonic, 3FO -24 -14 dBm  $P_{OUT} \le 28.0 dBm$ , all power modes. Spurious Output Level -60 dBc All spurious, P<sub>OUT</sub> ≤ 28dBm, all conditions, load VSWR  $\leq$  6:1, all phase angles. Insertion Phase Shift -30 5.6 +30 Phase shift at 16dBm when switching from HPM to LPM. DC Enable Time 10 μS DC only. Time from V<sub>FN</sub>=high to stable idle current (90% of steady state value). RF Rise/Fall Time  $P_{OUT} \le 28.0 dBm$ , all modes. 90% of target, DC μS settled prior to RF. Ruggedness 10:1 **VSWR** HPM, P<sub>OUT</sub>=28.0dBm, all phases. Coupling Factor 20 dB  $P_{OLIT} \le 28.0$ dBm, all modes. Daisy Chain Insertion Loss 0.25 dB CPL\_IN to CPL\_OUT port, V<sub>EN</sub>=0.5V 20 dB Coupling Directivity

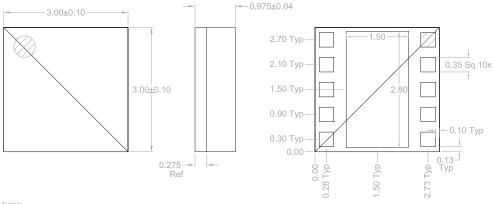


Pin	Function	Description	
1	VBAT	Supply voltage for bias circuitry.	
2	RF IN	RF input internally matched to $50\Omega$ and DC blocked. The RF input matching circuit has a shunt inductor to ground which would short any DC voltage placed on this pin.	
3	NC	No connection.	
4	VMODE	Digital control input for power mode selection (see Operating Modes truth table).	
5	VEN	Digital control input for PA enable and disable (see Operating Modes truth table).	
6	CPL_OUT	Coupler output.	
7	GND	This pin must be grounded.	
8	CPL_IN	Coupler input used for cascading couplers in series. Terminate this pin with a $50\Omega$ resistor if not connected to another coupler.	
9	RF OUT	RF output internally matched to $50\Omega$ and DC blocked.	
10	VCC	Supply voltage for the first and second stage amplifiers, which can be connected to battery supply or output of DC-DC converter.	
Pkg Base	GND	Ground connection. The package backside should be soldered to a topside ground pad connecting to the PCB ground plane with multiple ground vias. The pad should have a low thermal resistance and low electrical impedance to the ground plane.	

## **Operating Mode Truth Table**

$V_{EN}$	V <sub>MODE</sub>	V <sub>BAT</sub>	v <sub>cc</sub>	Conditions/Comments
Low	Low	3.0V to 4.2V	3.0V to 4.2V	Power down mode
Low	Х	3.0V to 4.2V	3.0V to 4.2V	Standby Mode
High	Low	3.0V to 4.2V	3.0V to 4.2V	High power mode
High	High	3.0V to 4.2V	3.0V to 4.2V	Low power mode

# **Package Drawing**

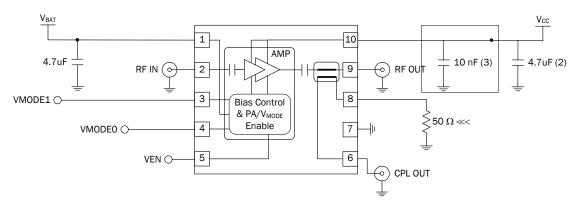


- 1. Shaded area represents Pin 1 location
- Defining I/O Pad Center:
   To define center of the I/O pad oepning, draw a right triangle in one corner of the I/O pad
   Then take the center of the hypotenuse to determine center

  - of I/O pad



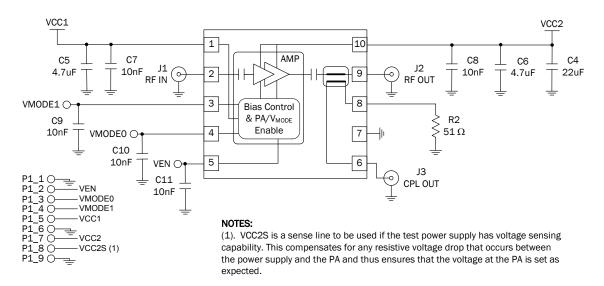
# **Application Schematic**



### NOTES:

- (1). The 50  $\Omega$  resistor should be removed if pin 8 is connected to another coupler for daisy chaining multiple couplers.
- (2). This capacitance value can be reduced for multi-PA with DC to DC converter applications where a total maximum capacitive load is required to be met. Keeping at least a 1uF capacitor close to the PA Vcc pin is recommended.
- (3). A capacitor of at least 10 nF should be placed closed to the PA VCC pin (pin10) for optimum decoupling.

## **Evaluation Board Schematic**





# **PCB Design Requirements**

### **PCB Surface Finish**

The PCB surface finish used for RFMD's qualification process is electroless nickel, immersion gold. Typical thickness is  $3\mu$ inch to  $8\mu$ inch gold over  $180\mu$ inch nickel.

## **PCB Land Pattern Recommendation**

PCB land patterns for RFMD components are based on IPC-7351 standards and RFMD empirical data. The pad pattern shown has been developed and tested for optimized assembly at RFMD. The PCB land pattern has been developed to accommodate lead and package tolerances. Since surface mount processes vary from company to company, careful process development is recommended.

## **PCB Metal Land Pattern**

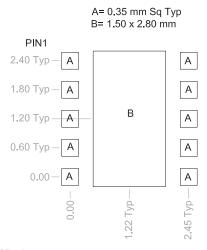


Figure 1. PCB Metal Land Pattern (Top View)



### PCB Solder Mask Pattern

Liquid Photo-Imageable (LPI) solder mask is recommended. The solder mask footprint will match what is shown for the PCB metal land pattern with a 2mil to 3mil expansion to accommodate solder mask registration clearance around all pads. The center-grounding pad shall also have a solder mask clearance. Expansion of the pads to create solder mask clearance can be provided in the master data or requested from the PCB fabrication supplier.

A= 0.49 mm Sq Typ B= 1.64 x 2.94 mm

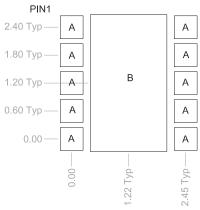


Figure 2. PCB Solder Mask Pattern (Top View)

### Thermal Pad and Via Design

The PCB land pattern has been designed with a thermal pad that matches the die paddle size on the bottom of the device.

Thermal vias are required in the PCB layout to effectively conduct heat away from the package. The via pattern has been designed to address thermal, power dissipation and electrical requirements of the device as well as accommodating routing strategies.

The via pattern used for the RFMD qualification is based on thru-hole vias with 0.203mm to 0.330mm finished hole size on a 0.5mm to 1.2mm grid pattern with 0.025mm plating on via walls. If micro vias are used in a design, it is suggested that the quantity of vias be increased by a 4:1 ratio to achieve similar results.